

MOSFET

Features

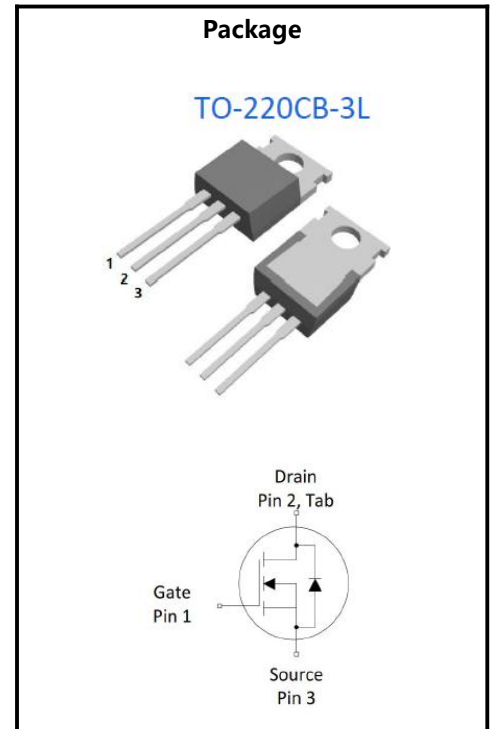
- ◆ Extremely low on-resistance $R_{DS(on)}$
- ◆ Excellent $Q_g \times R_{DS(on)}$ product(FOM)
- ◆ Excellent Low Ciss
- ◆ High robustness and reliability
- ◆ Increases maximum current capability
- ◆ Low power loss, high power density
- ◆ Easy paralleling

Applications

- ◆ Synchronous Rectification for AC/DC Quick Charger
- ◆ Battery management
- ◆ UPS(Uninterruptible Power Supplies)

Parameter	Values	Unit
BV_{DSS}	100	V
I_D	155	A
$R_{DS(on)}$ (max)	4	mΩ
$V_{GS(th)}$ (Typ)	3.0	V

155A,100V,4mΩ N-CHANNEL MOSFET



Ordering Code	Marking	Package	Packaging
X4N10GHP3	X4N10GHP3	TO-220CB-3L	Tube

Absolute Maximum Ratings($T_C=25^{\circ}\text{C}$, unless otherwise noted)

Parameter	Symbol	Values			Unit	Note/Test Conditions
		Min	Typ	Max		
Drain-Source Voltage	V_{DSS}	-	-	100	V	-
Gate-Source Voltage	V_{GS}	-20	-	20	V	-
Continuous Drain Current(Note 1)	I_D	-	-	155	A	$T_C=25^{\circ}\text{C}$
		-	-	98		$T_C=100^{\circ}\text{C}$
Pulsed Drain Current(Note 2)	I_{DM}	-	-	620	A	$T_C = 25^{\circ}\text{C}$, $t_p = 100\mu\text{s}$
Single Pulse Avalanche Energy	E_{AS}	-	-	300	mJ	$L=0.3\text{mH}$, $V_D=80\text{V}$, $T_C=25^{\circ}\text{C}$
Power Dissipation	P_D	-	-	179	W	$T_C=25^{\circ}\text{C}$
		-	-	1.7		$T_a=25^{\circ}\text{C}$
Operating Junction and Storage Temperature Range	T_{jv}, T_{STG}	-55	-	150	$^{\circ}\text{C}$	-

Thermal Characteristics

Parameter	Symbol	Values			Unit	Note/Test Conditions
		Min	Typ	Max		
Thermal resistance , Junction to Case	$R_{th(j-c)}$	-	0.48	0.7	$^{\circ}\text{C/W}$	-
Thermal resistance , Junction to Ambient	$R_{th(j-a)}$	-	-	73		-

Electrical Characteristics ($T_j=25^{\circ}\text{C}$, unless otherwise noted)

Static characteristics

Parameter	Symbol	Values			Unit	Note/Test Conditions
		Min	Typ	Max		
Drain-Source Breakdown Voltage	BV_{DSS}	100	-	-	V	$V_{GS}=0V, I_D=250\mu A$
Zero Gate Voltage Drain Current	I_{DSS}	-	0.02	1	μA	$V_{DS}=100V, V_{GS}=0V, T_j=25^{\circ}\text{C}$
		-	-	100		$V_{DS}=100V, V_{GS}=0V, T_j=150^{\circ}\text{C}$
Gate-Body Leakage Current	I_{GSS}	-	± 10	± 100	nA	$V_{GS}=20V, V_{DS}=0V$
Gate-Source Threshold Voltage	$V_{GS(th)}$	2.5	-	3.5	V	$V_{DS}=V_{GS}, I_D=250\mu A$
Drain-Source On-State Resistance	$R_{DS(on)}$	-	3.2	4.0	m Ω	$V_{GS}=10V, I_D=50A$
Gate Resistance	R_g	-	1.6	-	Ω	$V_{GS}=0V, V_{DS}=0V, f=1\text{MHz}$
Forward Transconductance	g_{fs}	-	81	-	S	$V_{DS}=5V, I_D=50A$

Dynamic characteristics

Parameter	Symbol	Values			Unit	Note/Test Conditions
		Min	Typ	Max		
Input Capacitance	C_{iss}	-	3783	-	pF	$V_{DS}=50V, V_{GS}=0V, f=1.0\text{MHz}$
Output Capacitance	C_{oss}	-	988	-		
Reverse Transfer Capacitance	C_{rss}	-	53	-		
Turn-On Delay Time	$t_{d(on)}$	-	21	-	ns	$V_{DD}=30V, I_D=50A, V_{GS}=10V, R_G=2.5\Omega$
Turn-On Rise Time	t_r	-	21	-		
Turn-Off Delay Time	$t_{d(off)}$	-	37	-		
Turn-Off Fall Time	t_f	-	10	-		

Gate charge characteristics

Parameter	Symbol	Values			Unit	Note/Test Conditions
		Min	Typ	Max		
Total Gate Charge	Q_g	-	64	-	nC	$V_{DS}=50V, I_D=50A, V_{GS}=10V$
Gate-Source Charge	Q_{gs}	-	21	-		
Gate-Drain Charge	Q_{gd}	-	13	-		

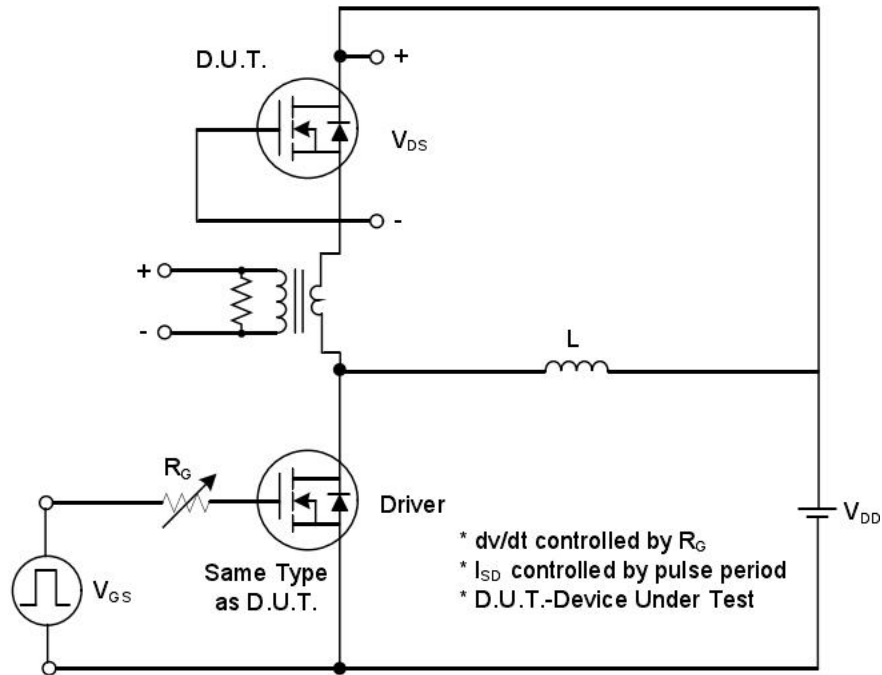
Reverse diode

Parameter	Symbol	Values			Unit	Note/Test Conditions
		Min	Typ	Max		
Continuous Diode Forward Current	I_S	-	-	155	A	-
Pulsed Diode Forward Current	I_{SM}	-	-	620	A	-
Diode Forward Voltage	V_{SD}	-	0.8	1.2	V	$I_S=20A, V_{GS}=0V$
Reverse Recovery Time	t_{rr}	-	54	-	ns	$V_{DS}=50V, V_{GS}=0V, I_S=50A$ $di/dt=100A/\mu s$
Reverse Recovery Charge	Q_{rr}	-	90	-	nC	

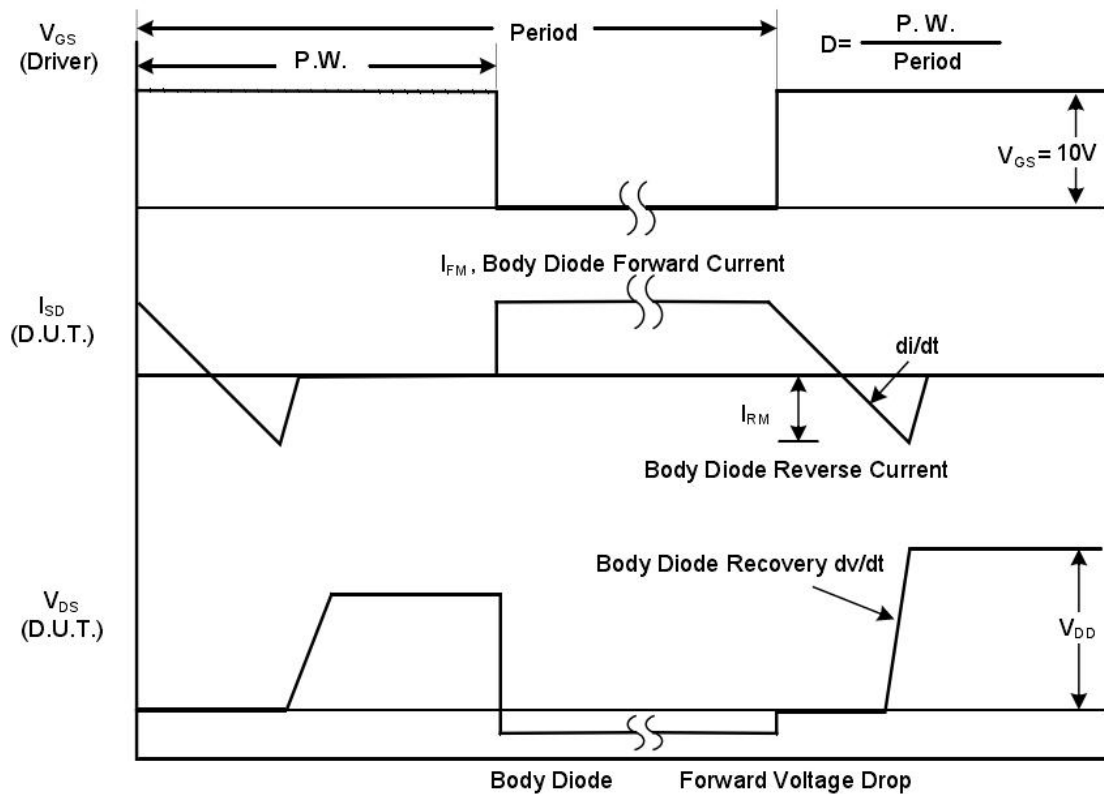
Notes

1. Computed continuous current assumes the condition of T_{j_Max} while the actual continuous current depends on the thermal & electro-mechanical application board design.
2. This single-pulse measurement was taken under $T_{j_Max} = 150^{\circ}\text{C}$.

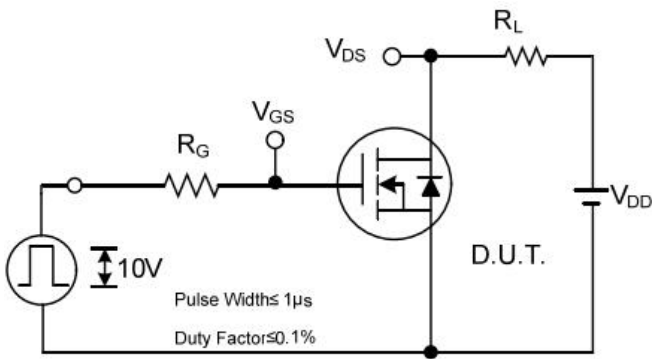
RATING AND CHARACTERISTIC CURVES



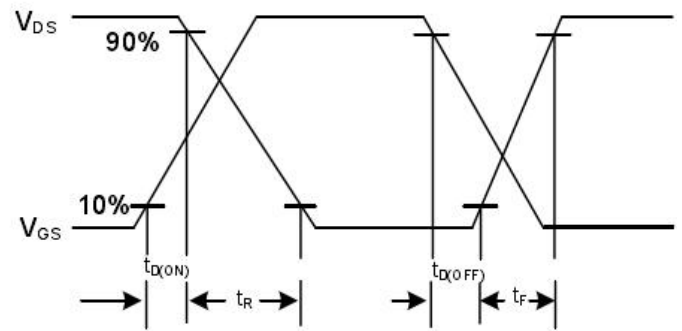
Peak Diode Recovery dv/dt Test Circuit



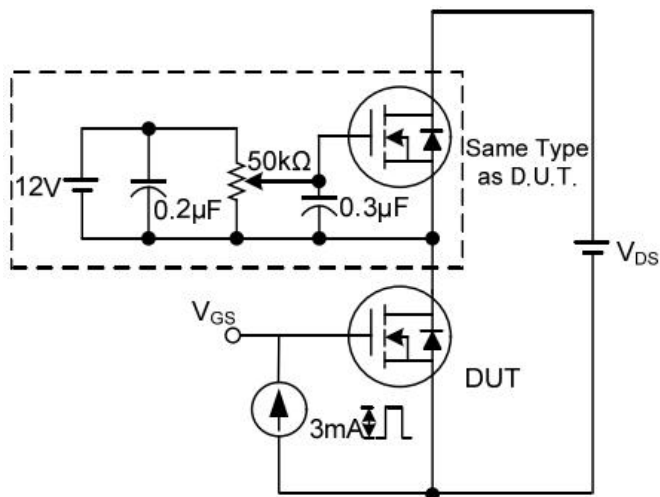
Peak Diode Recovery dv/dt Waveforms



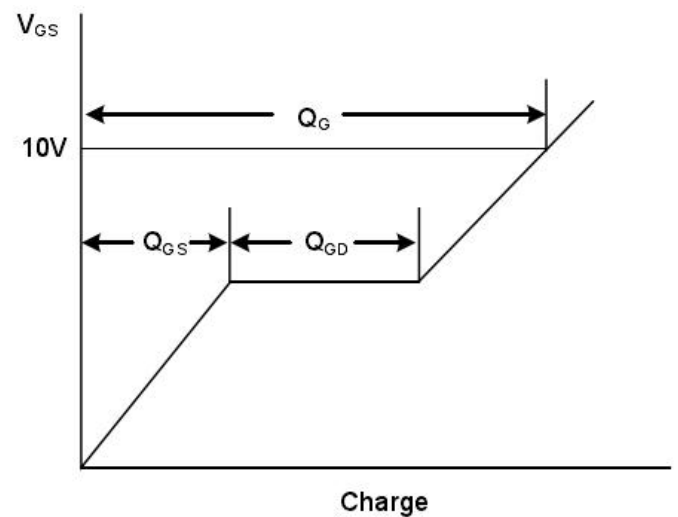
Switching Test Circuit



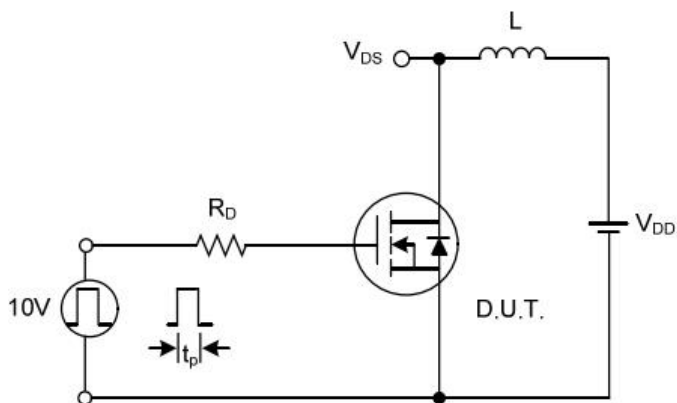
Switching Waveforms



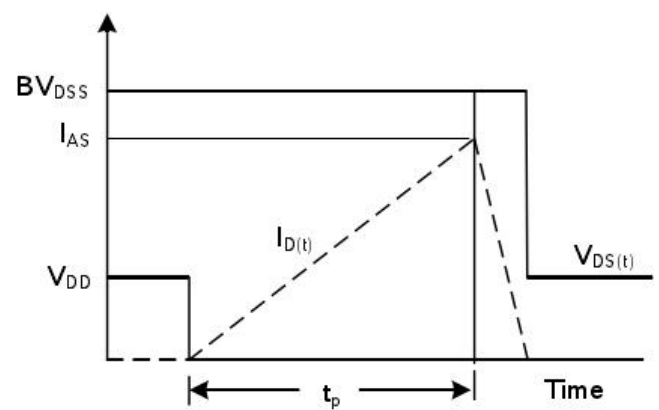
Gate Charge Test Circuit



Gate Charge Waveform



Unclamped Inductive Switching Test Circuit



Unclamped Inductive Switching Waveforms

RATING AND CHARACTERISTIC CURVES

Figure.1 Typical Output Characteristics

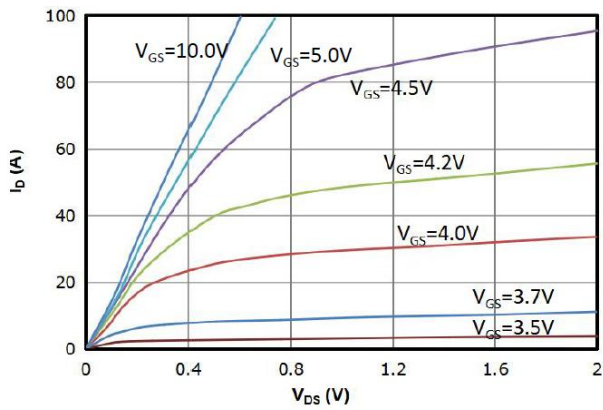


Figure.2 Transfer Characteristics

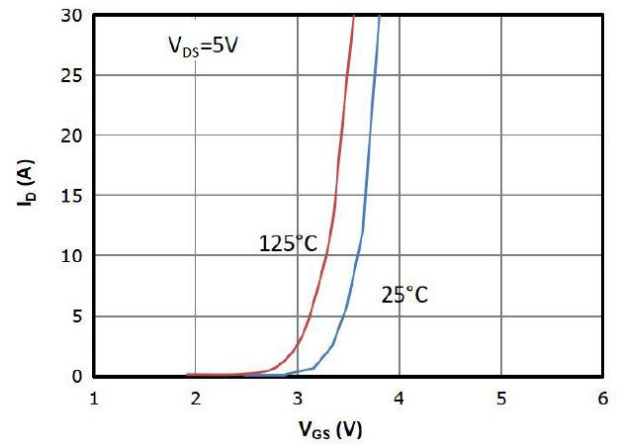


Figure.3 Rds(on) vs Drain Current and Gate Voltage

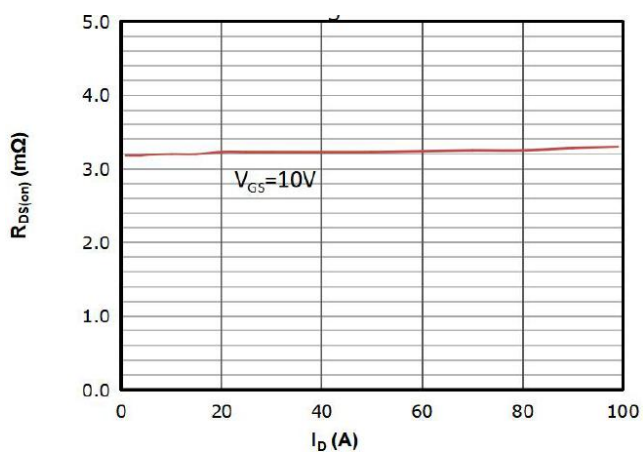


Figure.4 Rds(on) vs Gate Voltage

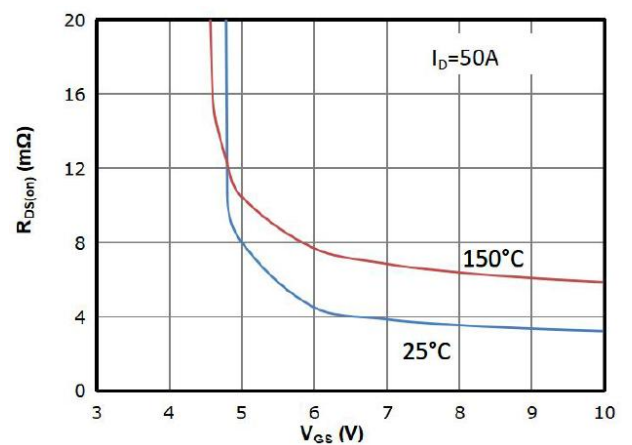


Figure.5 Rds(on) vs Temperature

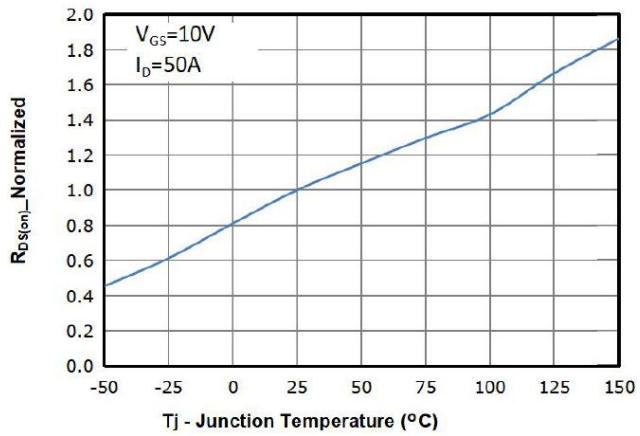


Figure.6 Vgs(th) vs Temperature

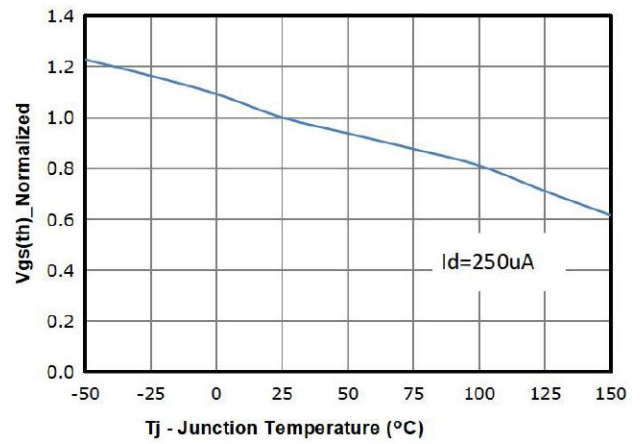


Figure.7 BVdss vs Temperature

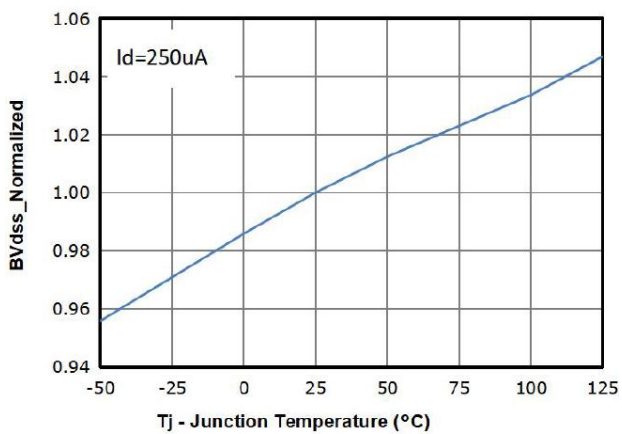


Figure.8 Capacitance Characteristics

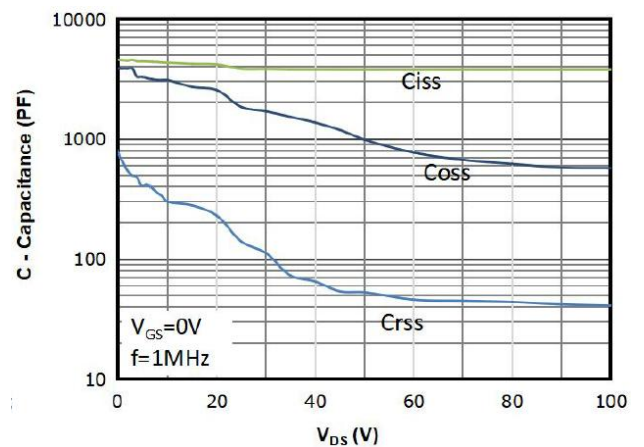


Figure.9 Gate Charge characteristics

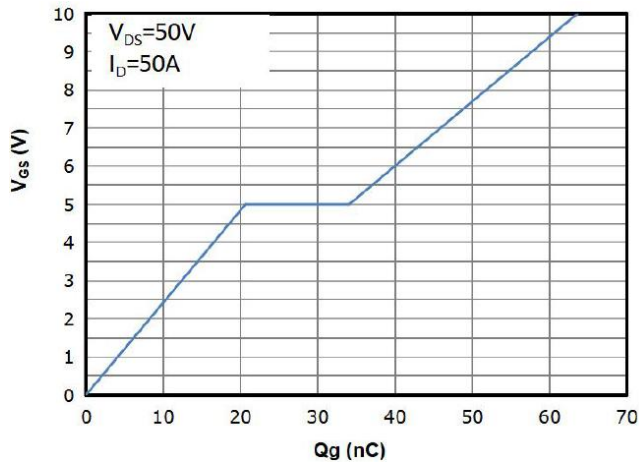


Figure.10 Body-Diode Forward Characteristics

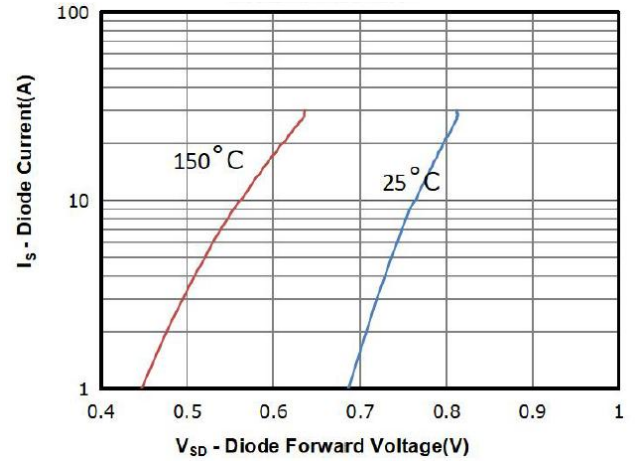


Figure.11 Power Dissipation

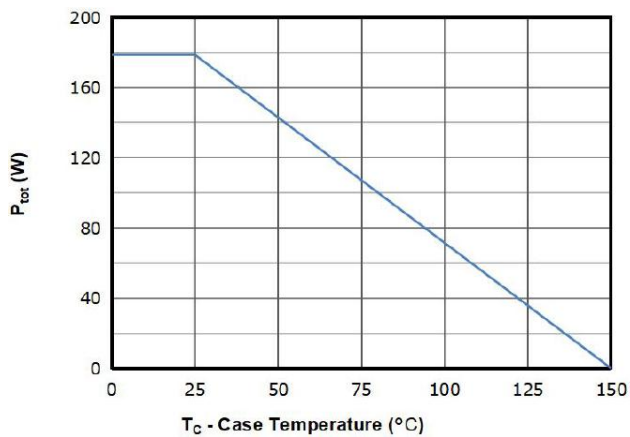


Figure.12 Drain Current Derating

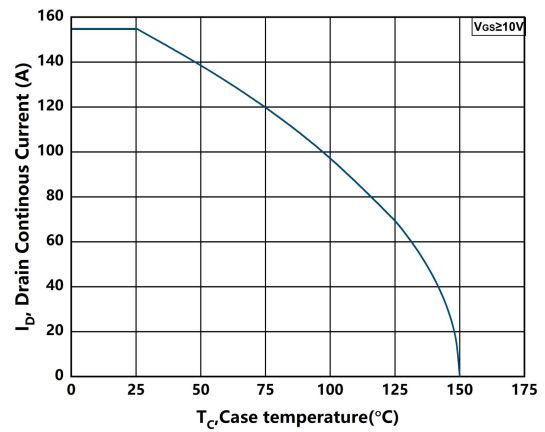


Figure.13 Safe Operating Area

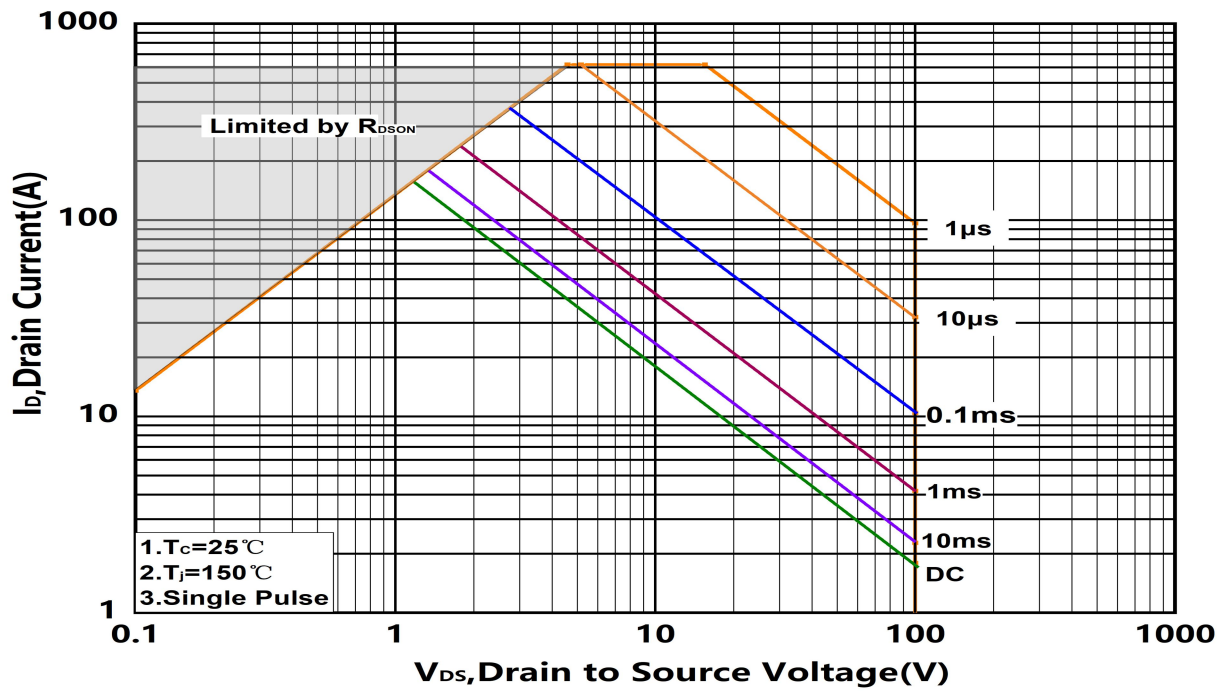
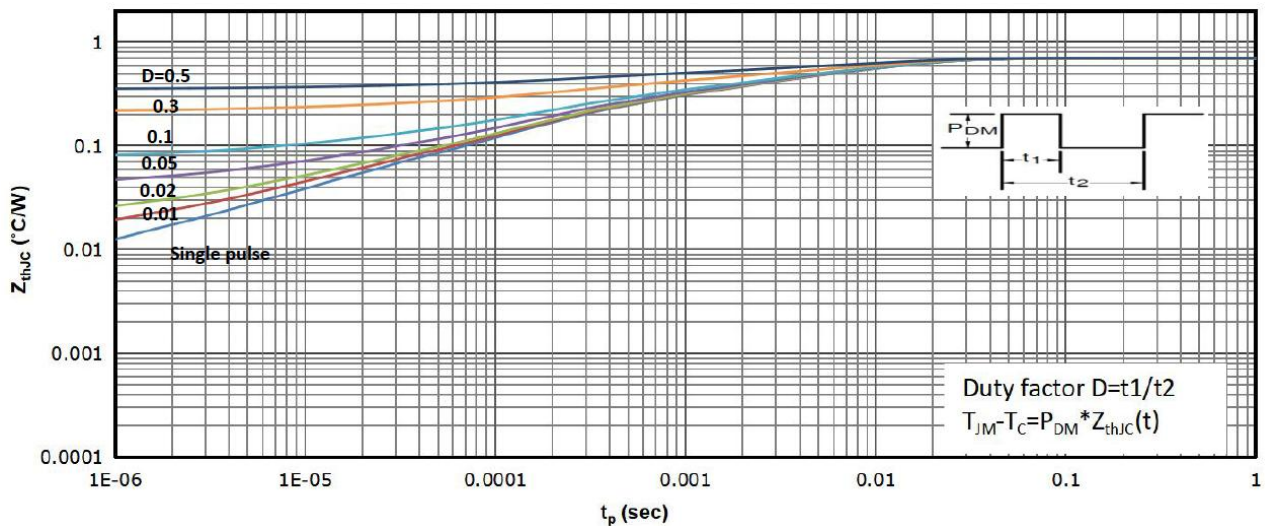
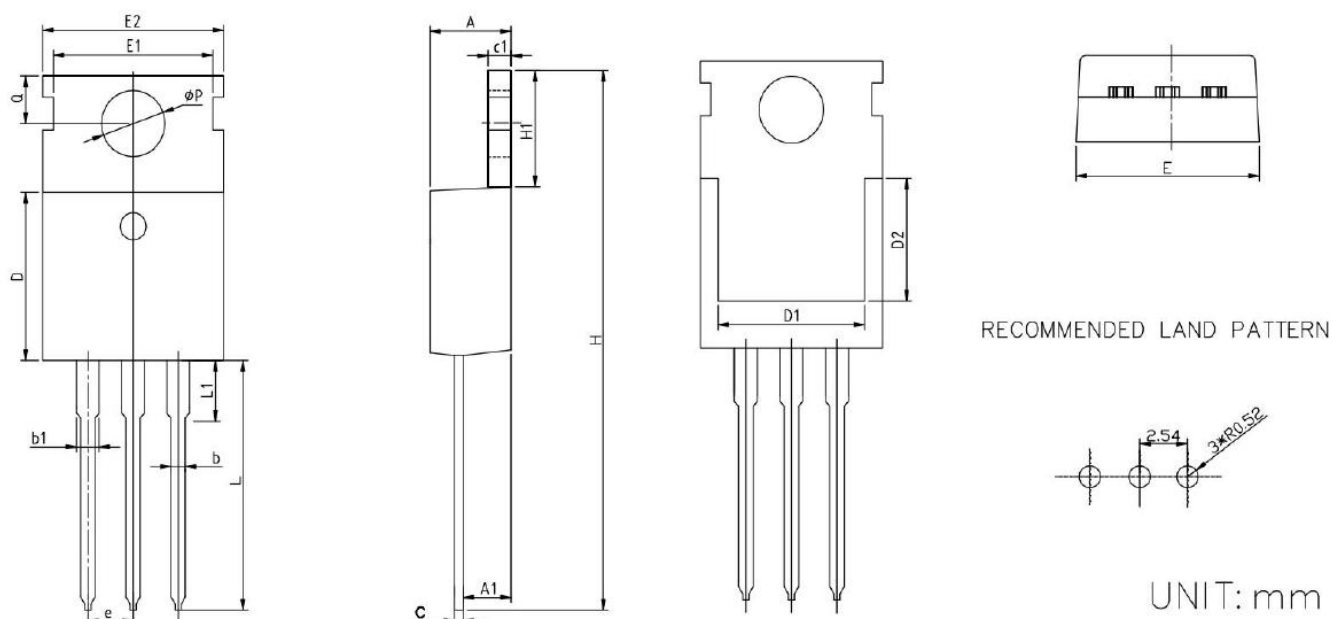


Figure.14 Max .Transient Thermal Impedance



Package Outline: TO-220CB-3L



SYMBOL	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	4.40	4.80	0.173	0.189
A1	2.25	2.55	0.089	0.100
b	0.72	0.92	0.028	0.036
b1	1.12	1.42	0.044	0.056
c	0.40	0.60	0.016	0.024
c1	1.20	1.40	0.047	0.055
D	8.80	9.40	0.346	0.370
D1	7.75	8.15	0.305	0.321
D2	6.55	6.95	0.258	0.274
e	2.54		0.100	
E	9.65	10.35	0.380	0.407
E1	8.70		0.343	
E2	9.70	10.30	0.382	0.406
H	28.70	29.70	1.130	1.169
H1	6.25	6.85	0.246	0.270
L	13.20	13.80	0.520	0.543
L1	2.80	3.40	0.110	0.134
Q	2.60	3.00	0.102	0.118
φP	3.45	3.75	0.136	0.148